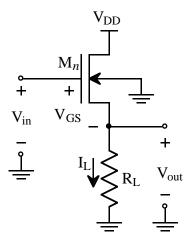
## Homework #4

Consider the circuit below which consists of an nMOS device and a resistor  $R_L$ . The input voltage  $V_{in}$  can be varied from 0V up to  $V_{DD}$ .



Derive an expression for the maximum value of  $V_{out}$ . Then calculate this maximum  $V_{out}$ . Do **not** neglect bulk bias effects. You may neglect channel length modulation. Since  $V_{Tn}$  is a function of  $V_{out}$ , you will have to iterate to the solution. First guess a value for  $V_{out}$ , calculate the corresponding value of  $V_{Tn}$ , then recalculate  $V_{out}$  using the calculated  $V_{Tn}$  value, and compare "old"  $V_{out}$  to the "new"  $V_{out}$ . Repeat this procedure until the "old" and "new" values of  $V_{out}$  agree within 10mV. Record your iterations within a table. Use  $V_{DD} = 5V$ ,  $\beta_n = 525~\mu\text{A}/V^2$ ,  $\gamma = 0.36~V^{1/2}$ ,  $V_{TOn} = 0.80V$ ,  $2|\phi_F| = 0.56V$ , and  $R_L = 40\text{k}\Omega$ . For convenience, the threshold expression is provided below.

$$V_{Tn} = V_{TOn} + \gamma \left( \sqrt{2|\phi_F| + V_{SB}} - \sqrt{2|\phi_F|} \right)$$